# **SPECIFICATION**

SPEC. No. A-Glue-b D A T E : 2015 Jan.

То

## **Non-Controlled Copy**

TDK PRODUCT NAME
MULTILAYER CERAMIC CHIP CAPACITORS
CGA Series / Automotive Grade
Conductive Epoxy Application

Please return this specification to TDK representatives.

If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

## **RECEIPT CONFIRMATION**

DATE:	YEAR	MONTH	DAY

TDK Corporation Sales Electronic Components Sales & Marketing Group TDK-EPC Corporation Engineering Ceramic Capacitors Business Group

APPROVED	Person in charge	APPROVED	CHECKED	Person in charge

### 1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over the other relevant specifications.

Production places defined in this specification shall be TDK-EPC Corporation Japan, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A. Inc.

### EXPLANATORY NOTE:

This specification warrants the quality of the ceramic chip capacitors. The chips should be evaluated or confirmed a state of mounted on your product.

If the use of the chips goes beyond the bounds of the specification, we can not afford to guarantee.

### 2. CODE CONSTRUCTION

(Example)

_/										
Catalog Number :	CGA4	J	3	X7R	<u>1E</u>	105	K	<u>125</u>	<u>A</u>	<u>D</u>
(Web)	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)	(10)
Item Description :	CGA4	J	3	X7R	<u>1E</u>	105	K	<u> </u>	***	B
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(11)	(12	2)



Please refer to product list for the dimension of each product.

#### (2) Thickness

\* As for dimension tolerance, please contact with our sales representative.

Thickness	Dimension(mm)
В	0.50
С	0.60
E	0.80
F	0.85
Н	1.15
J	1.25
L	1.60
М	2.00
Р	2.50

Sign	Condition
1	Rated Voltage x 1
2	Rated Voltage x 2
3	Rated Voltage x 1.5

(3) Voltage condition in the life test (Max. Operating Temp./1000h)



(5) Rated Voltage

Symbol	Rated Voltage
2 A	DC 100 V
1 H	DC 50 V
1 V	DC 35 V
1 E	DC 25 V
1 C	DC 16 V
0 J	DC 6.3 V

#### (6) Rated Capacitance

Stated in three digits and in units of pico farads (pF).

The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

R is designated for a decimal point.

(7) Capacitance tolerance

Symbol	Tolerance	Capacitance
C	± 0.25 pF	· · ·
D	± 0.5 pF	10pF and under
J	± 5%	
К	± 10 %	Over 10 pF
М	± 20 %	

- (8) Thickness code (Only Catalog Number)
- (9) Package code (Only Catalog Number)
- (10) Special code (Only Catalog Number)
- (11) Packaging (Only Item Description) (Bulk is not applicable for CGA2 type.)

Symbol	Packaging
В	Bulk
Т	Taping

(12) TDK Internal code (Only Item Description)

B : For Conductive glue mounting



### 3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

Class	Temperature Characteristics	Capacitar	nce tolerance	Rated capacitance
		10pF and	C (±0.25pF)	1, 1.5, 2, 2.2, 3, 3.3, 4, 4.7, 5
1	C0G	under	D (±0.5pF)	6, 6.8, 7, 8, 9, 10
		Over 10pF	J (± 5 %) K (± 10 %)	E – 12 series
2	X7R X8R	K (± 10 %) M (± 20 %)		E – 6 series

#### 3.1 Standard combination of rated capacitance and tolerances

### 3.2 Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.0 1.5 2.2 3.3 4.7 6.8							.8				
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

### 4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
C0G	-55°C	125°C	25°C
X7R	-55°C	125°C	25°C
X8R	-55°C	150°C	25°C

### 5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

### 6. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the industrial Waste Law.

### 7. MEASURES FOR CORROSIVE GAS

In order to avoid the failures which are caused by corrosive gas, chip capacitors must be sealed with silicon resin or equivalent.



### 8. PERFORMANCE

table 1

		1	table 1				
No.	Item	Perfor	mance		Test or ins	pection meth	nod
1	External Appearance	No defects which performance.	Inspect v	with magni	fying glass (3	3×).	
2	Insulation Resistance	(As for the capacit voltage 16, 10 and MΩ or 100MΩ·μF	10,000MΩ or 500MΩ· $\mu$ F min. (As for the capacitors of rated voltage 16, 10 and 6.3V DC, 10,000 MΩ or 100MΩ· $\mu$ F min.,) whichever smaller.			e for 60s.	
3	Voltage Proof	Withstand test vol insulation breakdo damage.	1 to 5s.	ss1 s2 2 C voltage	Apply volta 3 × rated vo 2.5 × rated v shall be apple current sha	Itage oltage lied for	
4	Capacitance	Within the specifie	ed tolerance.	measurii		<ul> <li>1MHz±10%</li> <li>1kHz±10%</li> <li>1kHz±10%</li> <li>1kHz±10%</li> <li>ich product h please cont</li> </ul>	
5	Q (Class1)	Rated Capacitance 30pF and over Under 30pF C : Rated capacita	1,000 min. 400+20×C min.	See No.		ole for meas	uring
6	Dissipation Factor (Class2)		D.F. 0.03 max. 0.05 max. 0.075 max. 0.1 max.	conditior For infor Dissipati	n. mation whi	ole for measi ich product h please conta e.	nas which



(		1		1	
No.	Item		Performance		Test or inspection method
7	Temperature Characteristics of Capacitance (Class1)	T.C. C0G Capacita ±0.05pF,	Temperature Coefficient (ppm/°C) $0 \pm 30$ nce drift within $\pm 0.2\%$ or whichever larger.	calcula 85°C te Measu	rature coefficient shall be ited based on values at 25°C and emperature. ring temperature below 20°C shall °C and -25°C.
8	Temperature Characteristics of Capacitance (Class2)		acitance Change (%) No voltage applied X7R : ±15 X8R : ±15	steps s therma step. $\Delta C$ be Ste 1 2 3 4 Measu As for t 10V D0 shall be For info	Reference temp. ± 2         Min. operating temp. ± 2         Reference temp. ± 2
9	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.		substra conduc force o	the capacitors on an Alumina ate shown in Appendix 1 with ctive glue and apply a pushing f 5N with 10±1s. applicable for CGA2 type) Pushing force Alumina substrate



۱o.	Ite	em	Performance			Test or inspection method		
10	Vibration	External	No mechanical	da	amage.	Mount	the capacitors on an	Alumina
		appearance				substra	ate shown in Append	lix 1 with
		Capacitance				condu	ctive glue before test	ing.
			Characteristics Change from the value before test		Vibrate	e the capacitor with f	ollowing	
			Class1 C0G		2.5% or ±0.25pF, hichever larger.	conditi		0
			Class2 X7R X8R		± 7.5 %		d force : 5G max.	
						-	ency : 10-2000Hz	
		Q					on : 20 min. 12 cycles in each 3 i	mutually
		(Class1)	Rated Capacitan	ce	Q	-	dicular directions.	Thataany
			30pF and over	-	1,000 min.			
			Under 30pF		400+20×C min.			
			C : Rated capacitance (pF)					
		D.F.	Meet the initial spec.			_		
	(Class2)							
11	Temperature	External	No mechanical	da	amage.	Mount the capacitors on an Alumina substrate shown in Appendix 1 with		
	cycle	appearance						
		Capacitance				condu	ctive glue before test	ing.
			Characteristics		Change from the value before test	Expos	e the capacitors in th	e condition
			Class1 C0G		2.5% or ±0.25pF, hichever larger.	step1 through step 4 and repeat 1,00 times consecutively.		
			Class2 X7R X8R		± 7.5 % ± 12.5 %			
							the capacitors in am	
		Q					on for 6 to 24h (Clas	,
		(Class1)	Rated Capacitan	œ	Q	24±2n	(Class 2) before me	asurement.
			30pF and over	•	1,000 min.	Step	Temperature(°C)	Time (min.
			Under 30pF		400+20×C min.	· · ·	,	
			C : Rated capacitance (pF) Meet the initial spec.		1	Min. operating temp. ±3	30 ± 3	
		D.F.			ec.	2	Reference Temp.	2 - 5
		(Class2)					Max. operating	
		Insulation	Meet the initial	sp	ec.	3	temp. ±2	30 ± 2
		Resistance				4	Reference Temp.	2 - 5
		Voltage	No insulation b	rea	akdown or	4	Relefence temp.	2-5
		proof	other damage.					



No.	Ite	em		Perfo	ormance	Test or inspection method	
12	Moisture	External	No mech	anical	damage.	Mount the capacitors on an Alumina	
	Resistance	appearance				substrate shown in Appendix 1 with	
	(Steady State)	Capacitance	Characteristics Change from the value before test			conductive glue before testing.	
			Class1		±5% or ±0.5pF, whichever larger.	Leave at temperature $40\pm2^{\circ}$ C, 90 to 95%RH for 500 +24,0h.	
			Class2	X7R X8R	± 12.5 % ± 25 %	Leave the capacitors in ambient	
						condition for 6 to 24h (Class1) or	
		Q				$24\pm 2h$ (Class2) before measurement.	
		(Class1)	Rated C	apacitano	e Q		
				and over	350 min.		
				and over er 30pF	275+5/2×C min.		
			Unde	er 10pF	200+10×C min.		
			C : Rate	d capac	citance (pF)		
		D.F. (Class2)	Characte 200% o		spec. max.		
			ne capa ∣6, 10 a )MΩ∙μF	citors of rated nd 6.3V DC, 1,000 min.,)			
3	Moisture Resistance	External appearanc	No mechanical damage.			Mount the capacitors on an Alumina substrate shown in Appendix 1 with conductive glue before testing.	
		e					
		Capacitance	Charact	eristics	Change from the value before test	Apply the rated voltage at temperatur 85°C and 85%RH for 1,000 +48,0h.	
			Class1		±7.5% or ±0.75pF, whichever larger.	Charge/discharge current shall not	
			Class2	X7R X8R	± 12.5 % ± 25 %	exceed 50mA.	
						Leave the capacitors in ambient condition for 6 to 24h (Class1) or	
		Q				$24\pm2h$ (Class2) before measurement.	
		(Class1)		apacitanc			
			30pF	and over	200 min.	Voltage conditioning (only for class2)	
			Unde	er 30pF	100+10/3×C min.	Voltage treat the capacitor under testing temperature and voltage for	
			C : Rated capacitance (pF)		itance (pF)	1hour.	
		D.F. (Class2)	Characte 200% o		spec. max.	Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial	
		Insulation Resistance	500MΩ or 25MΩ·μF min. (As for the capacitors of rated voltage 16, 10 and 6.3V DC, 500 MΩ or 5MΩ·μF min.,) whichever smaller.		citors of rated nd 6.3V DC, 500 min.,)	value.	



No.	o. Item		Performance			Test or inspection method	
14	Life	External appearance	No mechanical damage.		damage.	Mount the capacitors on an Alumina substrate shown in Appendix 1 with conductive glue before testing.	
		Capacitance	Characteristics Change from the value before test		before test	maximum operating temperature ±2°C	
			Class1	C0G	±3% or ±0.3pF, whichever larger.	for 1,000 +48, 0h.	
			X7R	± 15 %	Applied voltage		
			Class2	X8R	± 25 %	Rated voltage x2	
						Rated voltage x1.5	
						Rated voltage x1	
		Q (Class1)	Deted C	apacitan	ce Q		
		(Class I)		and over		For information which product has which applied voltage, please contact	
			10pF	and over er 30pF		with our sales representative.	
			Under 10pF		200+10×C min.	Charge/discharge current shall not	
			C : Rated capacitance (pF) Characteristics 200% of initial spec. max.			exceed 50mA. Leave the capacitors in ambient condition for 6 to 24h (Class1) or 24±2h (Class2) before measurement.	
		(Class2) Insulation Resistance					
			1,000MΩ or 50MΩ·μF min. (As for the capacitors of rated voltage 16, 10 and 6.3V DC, 1,000 MΩ or $10MΩ·μF$ min.,) whichever smaller.		acitors of rated and 6.3V DC, 1,00 F min.,)	Voltage conditioning (only for class2) Voltage treat the capacitor under testing temperature and voltage for 1hour. Leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	

\*As for the initial measurement of capacitors (Class2) on number 8,10,11 and 12, leave capacitors at 150 -10,0°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





Material : Alumina substrate

Alumina substrate thickness : Appendix-1 0.8mm

AgPt
Glass

Glass resist

Caution for mounting with conductive glue (Refer to the page 12.)

	Dimensions (mm)			
TDK (EIA style)	а	b	С	
CGA2 (CC0402)	0.5	1.4	0.5	
CGA3 (CC0603)	0.9	2.7	1.2	
CGA4 (CC0805)	0.9	2.7	1.9	
CGA5 (CC1206)	1.8	4.0	2.0	
CGA6 (CC1210)	1.8	4.4	3.0	





## 9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL			
INO.	NAME	Class1	Class2		
1	Dielectric	CaZrO <sub>3</sub>	BaTiO₃		
2	Electrode	Nicke	l (Ni)		
3	Termination	Copper (Cu)			
4	Termination	AgPdCu			



## 10. Caution

No.	Process	Condition
1	Operating Condition (Storage,	<ul> <li>1-1. Storage</li> <li>1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> </ul>
	Transportation)	<ol> <li>The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur.</li> </ol>
		3) Avoid storing in sun light and falling of dew.
		<ol> <li>Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.</li> </ol>
		1-2. Handling in transportation
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 Handling in transportation)
2	Circuit design	2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.
		1) Do not use capacitors above the maximum allowable operating temperature.
		2) Surface temperature including self heating should be below maximum operating temperature.
		(Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)
		<ul> <li>3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.</li> <li>2-2. Operating voltage</li> </ul>
		1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, $V_{0-P}$ must be below the rated voltage.
		AC or pulse with overshooting, $V_{P-P}$ must be below the rated voltage. (1) and (2) (2) (2) (3), (4) and (5) (4) (4) (5) (4) (5) (4) (5) (4) (5) (4) (5) (5) (5) (5) (5) (5) (5) (5) (5) (5
		When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.
		Voltage         (1) DC voltage         (2) DC+AC voltage         (3) AC voltage
		Positional Measurement (Rated voltage)
		Voltage (4) Pulse voltage (A) (5) Pulse voltage (B)
		Positional Measurement (Rated voltage)



Process	Condition
Circuit design	<ol> <li>Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.</li> </ol>
	<ol> <li>The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.</li> </ol>
	2-3. Frequency When the capacitors (Class 2) are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.
Designing Alumina Substrate	<ul> <li>The amount of glue at the terminations has a direct effect on the reliability of the capacitors.</li> <li>1) The greater the amount of glue with low thickness of land, the higher risk of electrical connection by conductive glue.</li> <li>Design of land and the amount of glue must be considered well.</li> </ul>
	<ol> <li>Avoid using common land for multiple terminations and provide individual land for each terminations.</li> </ol>
Mounting	<ul> <li>4-1. Stress from mounting head</li> <li>1) If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitor to result in cracking. Please take following precautions.</li> <li>2) Adjust the bottom dead center of the mounting head to reach on the Alumina substrate surface and not press it.</li> <li>3) Adjust the mounting head pressure to be 1 to 3N of static weight.</li> <li>4-2. Amount of conductive glue Excessive glue will make a electrical connection under the chip. In sufficient glue may detach the capacitor from the Alumina substrate.</li> </ul>
	Excessive glue Electrical connection will be made under the chip.
	Adequate
	Insufficient glue Low robustness may cause contact failure or chip capacitor comes off the Alumina substrate.
	▲ Caution Designing Alumina Substrate



No.	Process	Condition
5	Coating and molding of the Alumina substrate	<ol> <li>When the Alumina substrate is coated, please verify the quality influence on the product.</li> <li>Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> <li>Please verify the curing temperature.</li> </ol>
6	Handling of loose chip capacitors	<ul> <li>1) If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care.</li> <li>Crack</li> <li>Floor</li> <li>2) Piling the Alumina substrate after mounting for storage or handling, the corner of the Alumina substrate may hit the chip capacitors of another board to cause crack.</li> </ul>
7	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.
8	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 (Informative) Calculation of the estimated life time and the estimated failure rate. (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.



No.         Process         Condition           9         Others         The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home applicances, amusement equipment, orputer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.           The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification equipment           (2) Transportation equipment         (2) Transportation equipment           (3) Medical equipment         (3) Medical equipment           (4) Power-generation control equipment         (3) Medical equipment           (5) Atomic energy-related equipment         (7) Transportation orthol equipment           (7) Transportation equipment         (7) Transportation control equipment           (7) Transportation equipment         (1) Descreption pervention/crime prevention equipment           (6) Power-generation control equipment         (2) Transportation control equipment           (7) Transportation equipment         (3) Other applications, pervention/crime prevention equipment <tr< th=""><th></th><th></th><th>1</th></tr<>			1
<ul> <li>A Caution</li> <li>A Cautio</li></ul>	No.	Process	Condition
	9		electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us. (1) Aerospace/Aviation equipment (2) Transportation equipment (3) Medical equipment (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or



### 11. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

1) Inspection No.
 2) TDK P/N
 3) Customer's P/N
 4) Quantity

\*Composition of Inspection No.

Example  $\underline{F} \underline{2} \underline{A} - \underline{OO} - \underline{OOO}$ (a) (b) (c) (d) (e)

a) Line code

b) Last digit of the year

c) Month and A for January and B for February and so on. (Skip I)

d) Inspection Date of the month.

e) Serial No. of the day

## 12. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging : 1,000pcs. As for CGA2 types, not available for bulk packaging.



## **13. TAPE PACKAGING SPECIFICATION**

### **1. CONSTRUCTION AND DIMENSION OF TAPING**

- 1-1. Dimensions of carrier tape
  - Dimensions of paper tape shall be according to Appendix 2, 3. Dimensions of plastic tape shall be according to Appendix 4.
- 1-2. Bulk part and leader of taping



1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 5, 6. Dimensions of Ø330 reel shall be according to Appendix 7, 8.

1-4. Structure of taping





### 2. CHIP QUANTITY

Туре	Thickness	Taping	Chip quantity(pcs.)		
туре	of chip	Material	φ178mm reel	φ330mm reel	
CGA2 (CC0402)	0.50 mm	Paper	10,000	50,000	
CGA3 (CC0603)	0.80 mm	Paper or Plastic	4,000	10,000	
CGA4	0.85 mm	Paper or Plastic	4,000	10,000	
(CC0805)	1.25 mm	Plastic	2,000		
	0.85 mm	Paper or Plastic	4,000	10.000	
CGA5 (CC1206)	1.15 mm	Plastic	2.000	10,000	
	1.60 mm	Flastic	2,000	8,000	
CGA6 (CC1210)	1.60 mm		2,000	8,000	
	2.00 mm	Plastic	1 000	5,000	
	2.50 mm		1,000		



### **3. PERFORMANCE SPECIFICATIONS**

- 3-1. Fixing peeling strength (top tape)
  - 0.05-0.7N. (See the following figure.)
- TYPE 1 (Paper)



### TYPE 2 (Plastic)



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. The fixing tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.



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\* The values in the parentheses ( ) are for reference.



						, ,
Symbol Type	А	В	С	D	Е	F
CGA3 (CC0603)	(1.10)	(1.90)				
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	(1.90)	(3.50)				
Symbol Type	G	Н	J	Т		
CGA3 (CC0603)						
CGA4 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10 0	1.20 max.		
CGA5 (CC1206)						

\* The values in the parentheses ( ) are for reference.





Plastic Tape



						(Unit : mm)
Symbol Type	А	В	С	D	Е	F
CGA3 (CC0603)	(1.10)	(1.90)				
CGA4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
CGA5 (CC1206)	(1.90)	(3.50)	[12.0 ± 0.30]	[5.50 ± 0.05]	1.75 ± 0.10	4.00 ± 0.10
CGA6 (CC1210)	(2.90)	(3.60)				
Symbol Type	G	Н	J	К	t	Q
CGA3 (CC0603)				1.50 max.		
CGA4 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 +0.10	2.50 max.	0.60 max.	Ø 0.50 min.
CGA5 (CC1206)	2.00 ± 0.00	4.00 ± 0.10	0	2.50 max.	0.00 max.	0.50 min.
CGA6 (CC1210)				3.20 max.		

 $^{\ast}$  The values in the parentheses ( ~ ) are for reference.

\* As for 2.5mm thickness products, apply values in the brackets [ ].





### **Appendix 6**

CGA6 (As for CGA6 type, applied to 2.5mm thickness products ) (Material : Polystyrene)

		r			₩2  	Unit : mm)
Symbol	А	В	С	D	E	W <sub>1</sub>
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	$2.0 \pm 0.5$	13.0 ± 0.3
Symbol	W <sub>2</sub>	r				
Dimension	17.0 ± 1.4	1.0				





### **Appendix 8**

CGA6 (As for CGA6 type, applied to 2.5mm thickness products) (Material : Polystyrene)

	1		A		₩ t	(Unit : mm)
Symbol	А	В	С	D	Е	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5
Symbol	t	r				
Dimension	2.0 ± 0.5	1.0	-			

